

Automation Analysis for Class 0 & CDM



Client Locations

Ted Dangelmayer www.dangelmayer.com



Hard at Work "Down Under"!

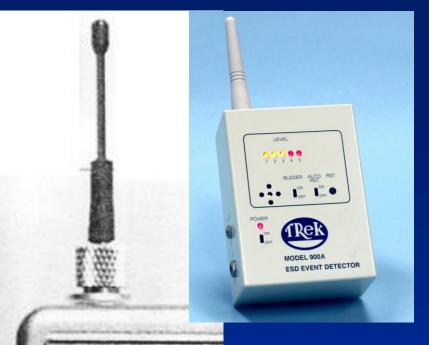


Agenda

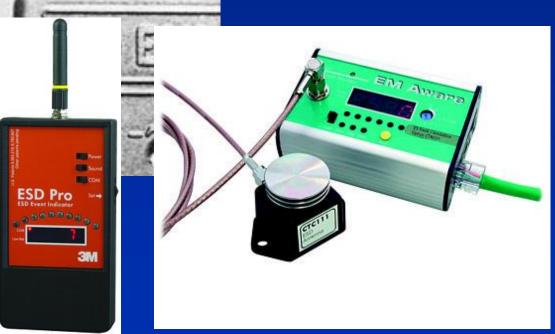
- Introduction
- Examples of Automation Issues
- Diagnostic Methods
- Materials Testing
- Corrective Action Trials
- 50 V Qualification Case Studies

Strategic Options to Begin Analysis Pros and Cons

- Detailed Resistance & Voltage Measurements
 - Process Surrogate Module
 - ESDA Working Group
- ESD Event Detection
 - Then Detailed Resistance & Voltage Measurements



Hand-held ESD Event Detectors Low cost alternative to high speed scopes





Event Detectors Useful for Workstation Analysis



Wafer Saw Class 0 Failures

- 90% failure rate
 - 30 volt CDM Withstand Voltage
- Complex Resolution
 - CO₂ Bubbler
 - Cutting Blade Material Change
 - Depth of Cut
 - Travers Speed

ESD Events at Contact with Solder Wave



Charged Carrier Tape



Events at Solder Past Tool



Die Attach



SMT ESD Events



Metal Automation Fixture

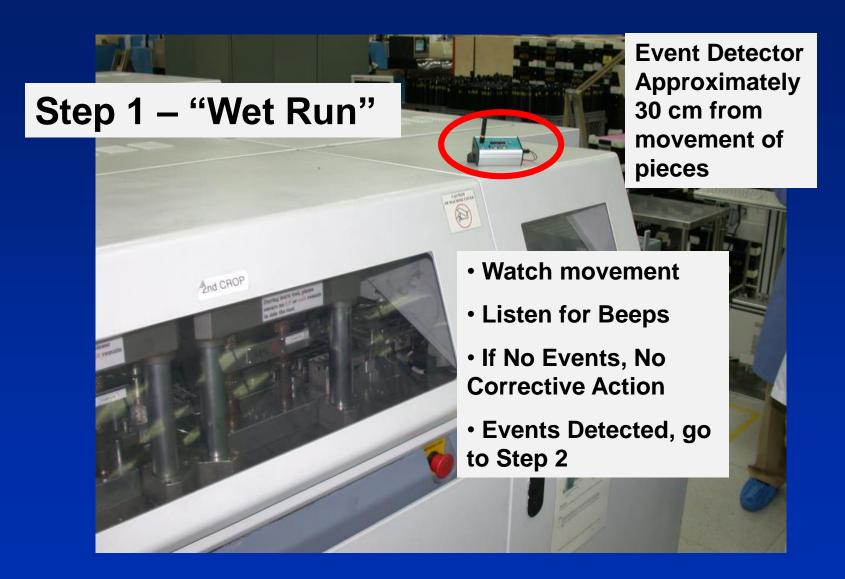


Events in Glove Box

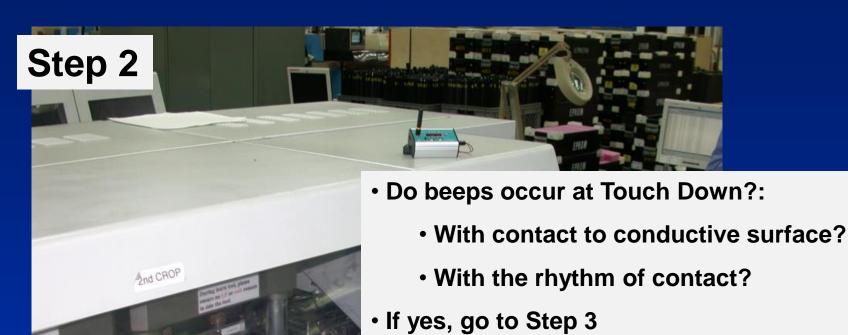


Diagnostic Methods

Initial Diagnostics

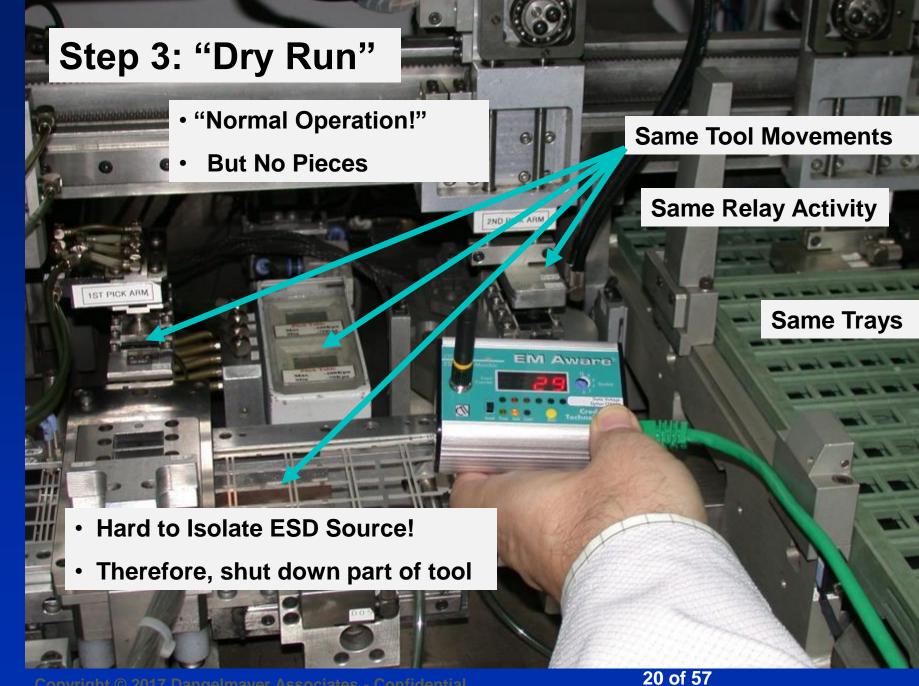


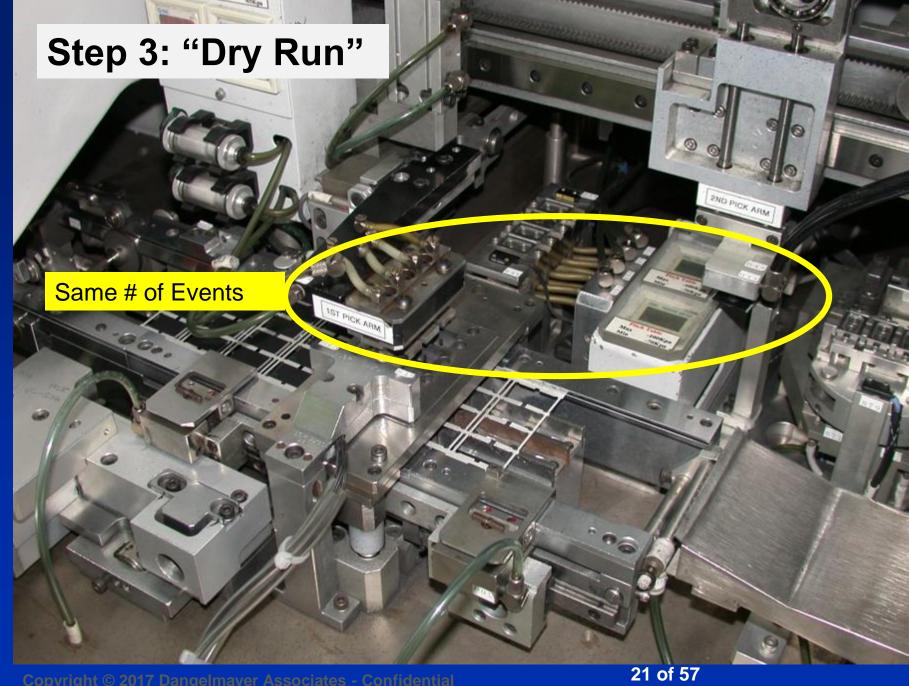
Initial Diagnostics

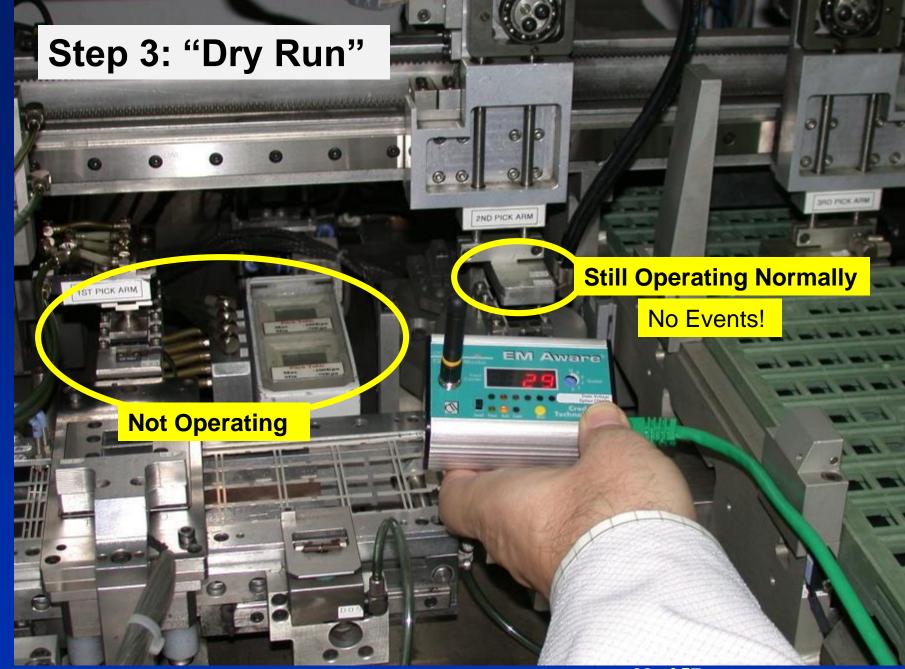


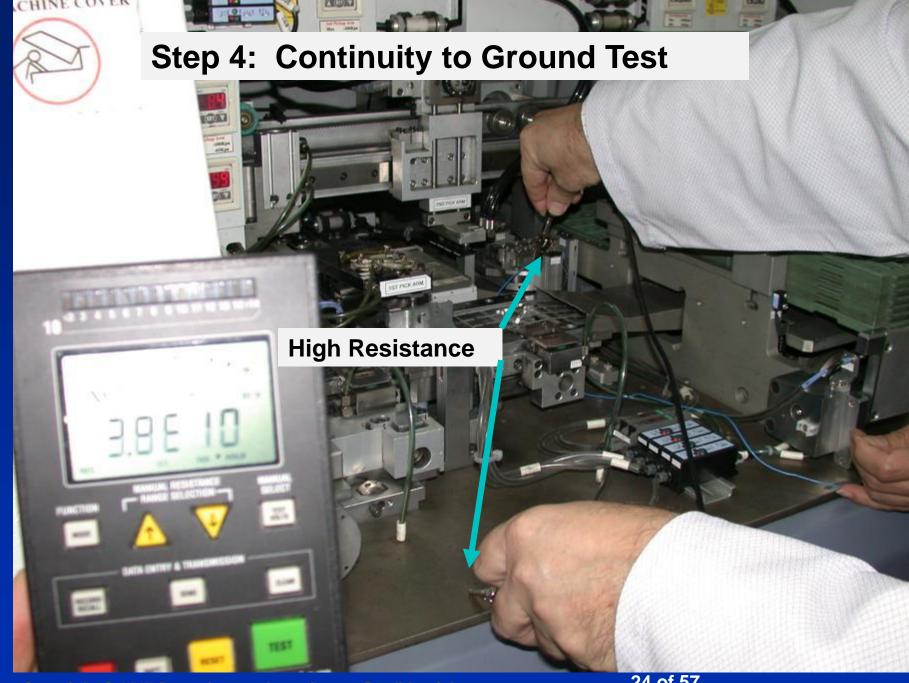
- Are the beeps EMI Interference?:
 - Come in bursts?
 - In rapid succession?
 - In rhythm with relays?
- If yes, go to Step 3

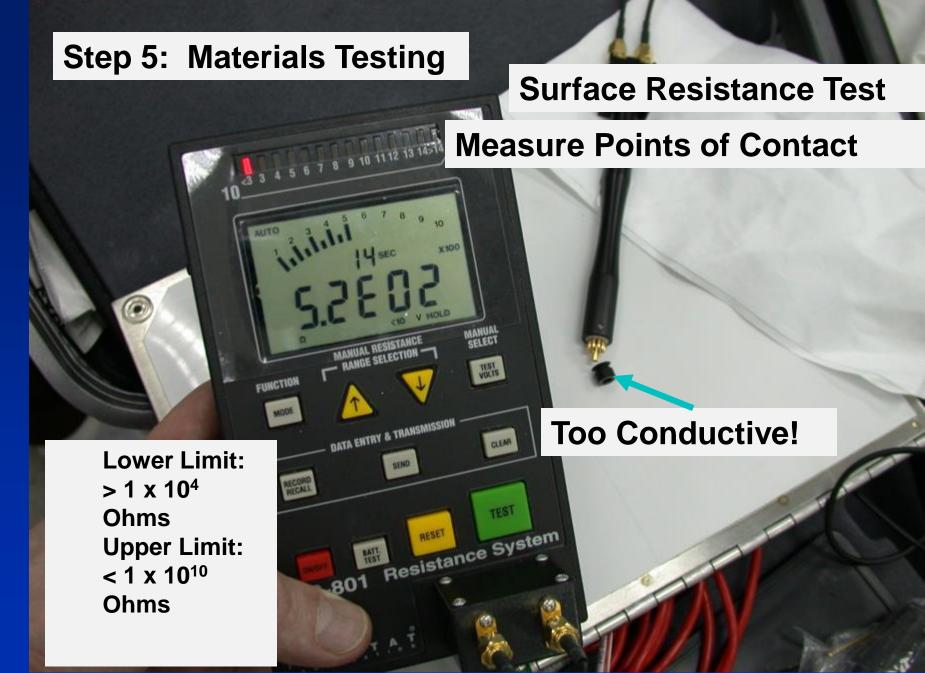


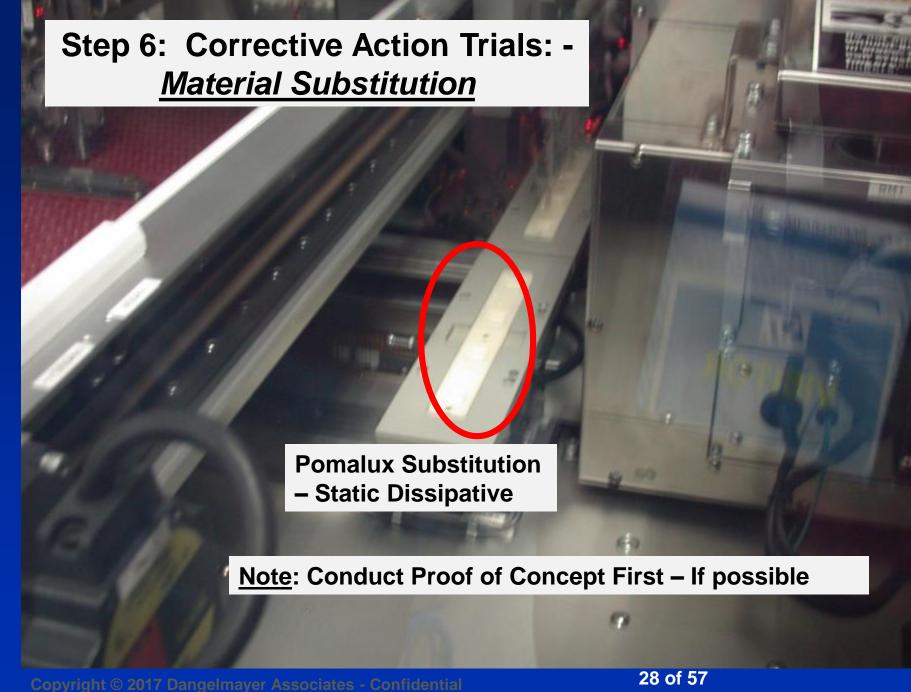














Do ESD Events Stop?

If yes, Repeat prior Steps to try to Correct Root Cause.

Add Ionization Only if other steps do not work!

Go to Next Step

Two Automation Case Studies Customer Requires 50 Volt Qualification

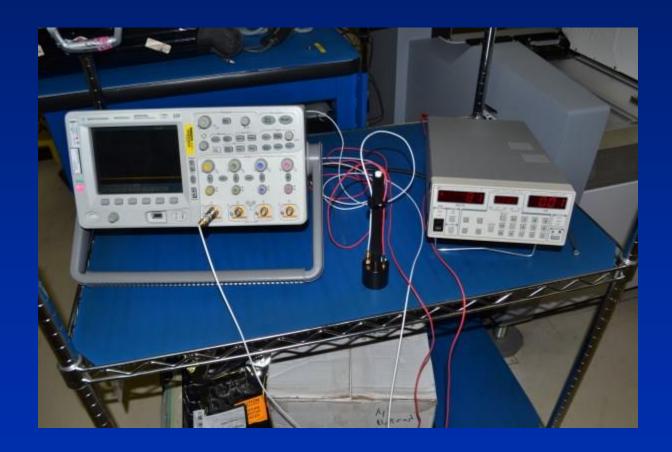
Class 000 (< 50 V) Automation Qualification

- Are Voltage Measurements the Correct Criteria?
 - No! Current (not Voltages) Causes IC Damage
 - Customers Require Class 000 Certification for 50 volt Devices
 - Often Current Thresholds Not Available
- Discharge Currents & Voltage
 - Difficult to Measure
 - Due to Process Speeds
 - Limited Access Points
 - Pausing for Measurements Alters Charge/Voltage Levels

Class 000 (< 50 V) Automation Qualification

- ESD Event Detection Good Option
 - Can be Correlated to Voltage on Devices in Automation Tool
 - Requires Calibration of Event Detectors
 - CDMES Provides Reproducible CDM Source In-situ
 - Creation of Calibration/Characterization Curves
 - Event Free Automation Ultimate Objective
 - Justification for 50 Volt Certification/Qualification

ESD Simulator & Test Equipment

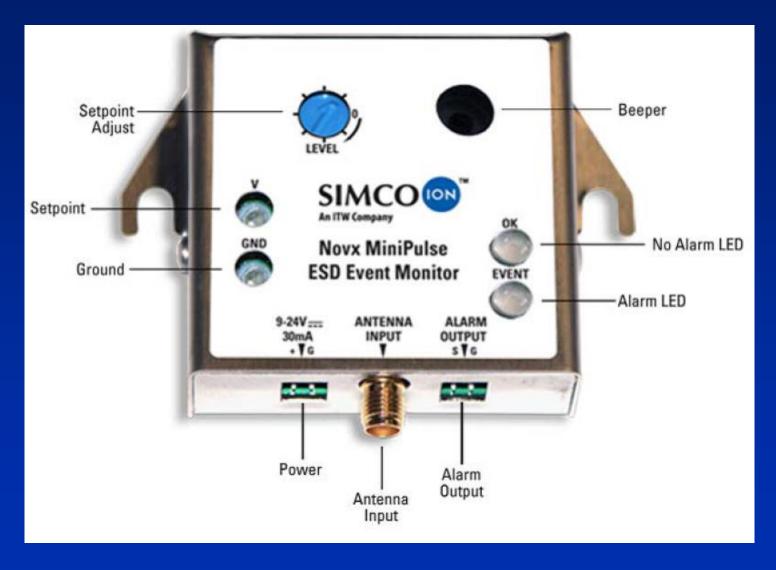




Simco-Ion Mini Pulse Set/Reject Table

Target	Distance	MP
Voltage	(inches)	Setting
50	1	1.228
75	1	1.265
100	1	1.329
150	1	1.387
200	1	1.421
250	1	1.454
300	1	1.474
350	1	1.633
400	1	1.662
500	1	1.694
600	1	1.729
700	1	1.798
900	1	1.817
1000	1	1.84

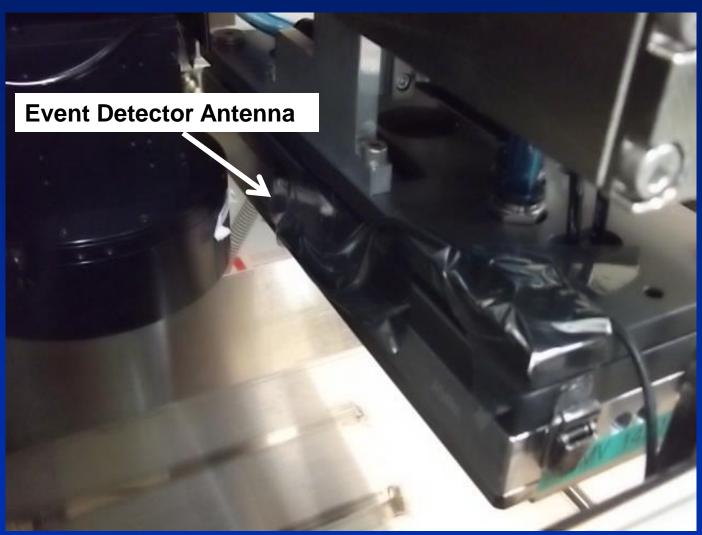
Simco-Ion MiniPulse



200 Volts on Device Evaluate Risk With Event Detection



200 Volts: No ESD Events Above 10 Volts



30 Volts on Device Evaluate Risk With Event Detection



30 Volts on Device ESD Events Detected – Must Determine Source!



Case Study #2: 50 Volt Qualification

MyData Automation Pick & Place Tool Case Study: 50 Volt Qualification



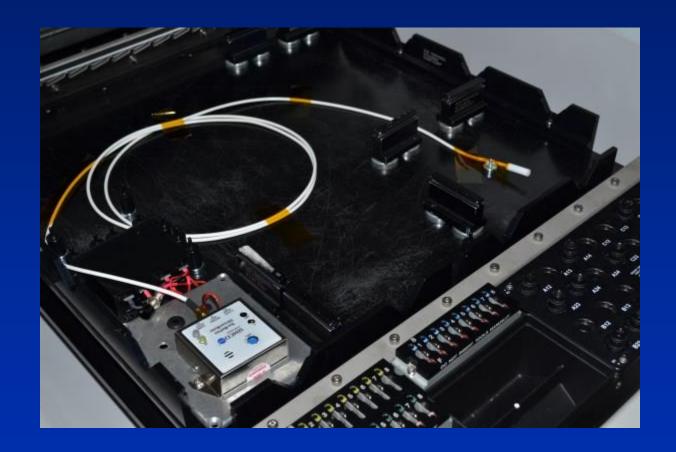
Tests Conducted

- Fields
 - Electrostatic Voltmeter
- Ionizer Performance
- Resistance Measurements
 - RTG; SRM
- Material Qualification
- ESD Event Detection
 - 50 Volt Sensitivity Settings

Circuit Board Input Tray



ESD Event Detector Location Circuit Board Input Tray



ESD Event Detector: Location and 50 V Sensitivity Setting



ESD Event Detector: Location and 50 V Sensitivity Setting



RF Interference: Vacuum Line Relay



RF Interference: Vacuum Pump Starter Capacitor



Input Tray Materials



Input Tray Materials



Input Tray Materials



Individual Device Input Tray: SRM - Dissipative Powder Coat Paint



SRM Double Sided Tape



Pick Up Nozzle RTG



Pick Up Nozzle Resistance



Questions?

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